

# High Voltage XPT™ IGBT w/ Diode

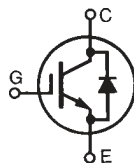
## IXYL40N250CV1

$$V_{CES} = 2500V$$

$$I_{C110} = 40A$$

$$V_{CE(sat)} \leq 4.0V$$

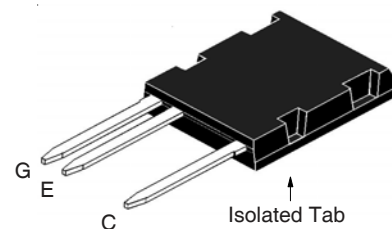
$$t_{fi(typ)} = 134ns$$



(Electrically Isolated Tab)

| Symbol                        | Test Conditions   | Maximum Ratings       |            |
|-------------------------------|---|-----------------------|------------|
| $V_{CES}$                     | $T_J = 25^\circ C$ to $175^\circ C$   | 2500                  | V          |
| $V_{CGR}$                     | $T_J = 25^\circ C$ to $175^\circ C$ , $R_{GE} = 1M\Omega$                           | 2500                  | V          |
| $V_{GES}$                     | Continuous  | $\pm 20$              | V          |
| $V_{GEM}$                     | Transient   | $\pm 30$              | V          |
| $I_{C25}$                     | $T_C = 25^\circ C$  | 80                    | A          |
| $I_{C110}$                    | $T_C = 110^\circ C$   | 40                    | A          |
| $I_{F110}$                    | $T_C = 110^\circ C$   | 23                    | A          |
| $I_{CM}$                      | $T_C = 25^\circ C$ , 1ms  | 380                   | A          |
| <b>SSOA</b><br><b>(RBSOA)</b> | $V_{GE} = 15V$ , $T_{VJ} = 150^\circ C$ , $R_G = 1\Omega$<br>Clamped Inductive Load | $I_{CM} = 80$<br>1500 | A<br>V     |
| $P_C$                         | $T_C = 25^\circ C$  | 577                   | W          |
| $T_J$                         |   | -55 ... +175          | $^\circ C$ |
| $T_{JM}$                      |   | 175                   | $^\circ C$ |
| $T_{stg}$                     |   | -55 ... +175          | $^\circ C$ |
| $T_L$                         | Maximum Lead Temperature for Soldering  | 300                   | $^\circ C$ |
| $T_{SOLD}$                    | 1.6 mm (0.062in.) from Case for 10s   | 260                   | $^\circ C$ |
| $F_C$                         | Mounting Force  | 40..120 / 9..27       | N/lb       |
| $V_{ISOL}$                    | 50/60 Hz, RM, t = 1min  | 2500                  | V~         |
| <b>Weight</b>                 |   | 8                     | g          |

### ISOPLUS i5-Pak™



G = Gate  
C = Collector

E = Emitter

### Features

- Silicon Chip on Direct-Copper Bond (DCB) Substrate
- Isolated Mounting Surface
- 4500V~ Electrical Isolation
- High Voltage Package
- High Blocking Voltage
- High Peak Current Capability
- Low Saturation Voltage

### Advantages

- Low Gate Drive Requirement
- High Power Density

### Applications

- UPS
- Motor Drives
- SMPS
- PFC Circuits
- High Frequency Power Inverters

| Symbol        | Test Conditions<br>( $T_J = 25^\circ C$ , Unless Otherwise Specified)                  | Characteristic Values |            |                    |
|---------------|--|-----------------------|------------|--------------------|
|               |  | Min.                  | Typ.       | Max.               |
| $BV_{CES}$    | $I_C = 250\mu A$ , $V_{GE} = 0V$   | 2500                  |            | V                  |
| $V_{GE(th)}$  | $I_C = 250\mu A$ , $V_{CE} = V_{GE}$   | 3.0                   |            | 5.0 V              |
| $I_{CES}$     | $V_{CE} = V_{CES}$ , $V_{GE} = 0V$<br>$V_{CE} = 0.8 \cdot V_{CES}$ $T_J = 125^\circ C$ |                       |            | 25 $\mu A$<br>5 mA |
| $I_{GES}$     | $V_{CE} = 0V$ , $V_{GE} = \pm 20V$   |                       |            | $\pm 100$ nA       |
| $V_{CE(sat)}$ | $I_C = 40A$ , $V_{GE} = 15V$ , Note 1<br>$T_J = 150^\circ C$                           |                       | 3.2<br>4.4 | V<br>V             |

| Symbol   | Test Conditions<br>( $T_J = 25^\circ\text{C}$ Unless Otherwise Specified)   | Characteristic Values |  |          |
|--|---|-----------------------|--|----------|
|  |   | Min.                  | Typ.   | Max.     |
| $g_{fs}$   | $I_C = 40\text{A}, V_{CE} = 10\text{V}$ , Note 1  | 24                    | 42   | S        |
| $R_{Gi}$   | Gate Input Resistance   |                       | 2.2  | $\Omega$ |
| $C_{ies}$<br>$C_{oes}$<br>$C_{res}$  | $V_{CE} = 25\text{V}, V_{GE} = 0\text{V}, f = 1\text{MHz}$  |                       | 5470   | pF       |
|  |   |                       | 280  | pF       |
|  |   |                       | 74   | pF       |
| $Q_{g(on)}$<br>$Q_{ge}$<br>$Q_{gc}$  | $I_C = 40\text{A}, V_{GE} = 15\text{V}, V_{CE} = 0.5 \cdot V_{CES}$   |                       | 270  | nC       |
|  |   |                       | 28   | nC       |
|  |   |                       | 110  | nC       |
| $t_{d(on)}$<br>$t_{ri}$<br>$E_{on}$<br>$t_{d(off)}$<br>$t_{fi}$<br>$E_{off}$ | <b>Inductive load, <math>T_J = 25^\circ\text{C}</math></b><br>$I_C = 40\text{A}, V_{GE} = 15\text{V}$<br>$V_{CE} = 0.5 \cdot V_{CES}, R_G = 1\Omega$<br>Note 2  |                       | 21   | ns       |
|  |   |                       | 22   | ns       |
|  |   |                       | 11.7   | mJ       |
|  |   |                       | 200  | ns       |
|  |   |                       | 134  | ns       |
|  |   |                       | 6.9  | mJ       |
| $t_{d(on)}$<br>$t_{ri}$<br>$E_{on}$<br>$t_{d(off)}$<br>$t_{fi}$<br>$E_{off}$ | <b>Inductive load, <math>T_J = 150^\circ\text{C}</math></b><br>$I_C = 40\text{A}, V_{GE} = 15\text{V}$<br>$V_{CE} = 0.5 \cdot V_{CES}, R_G = 1\Omega$<br>Note 2 |                       | 21   | ns       |
|  |   |                       | 22   | ns       |
|  |   |                       | 14.7   | mJ       |
|  |   |                       | 255  | ns       |
|  |   |                       | 250  | ns       |
|  |   |                       | 11.5   | mJ       |
| $R_{thJC}$<br>$R_{thCS}$   |   |                       | 0.26 $^\circ\text{C/W}$<br>0.15 $^\circ\text{C/W}$ |          |

**Reverse Sonic Diode (FRD)**

| Symbol               | Test Conditions<br>( $T_J = 25^\circ\text{C}$ Unless Otherwise Specified)   | Characteristic Values |                         |            |
|----------------------|---|-----------------------|-------------------------|------------|
|                      |   | Min.                  | Typ.                    | Max.       |
| $V_F$                | $I_F = 40\text{A}, V_{GE} = 0\text{V}$ , Note 1<br>$T_J = 150^\circ\text{C}$  |                       | 3.4                     | 4.0 V<br>V |
| $I_{RM}$<br>$t_{rr}$ | $I_F = 40\text{A}, V_{GE} = 0\text{V}, T_J = 150^\circ\text{C}$<br>$-di_F/dt = 600\text{A}/\mu\text{s}, V_R = 1200\text{V}$ |                       | 52                      | A          |
|                      |   |                       | 210                     | ns         |
| $R_{thJC}$           |   |                       | 0.83 $^\circ\text{C/W}$ |            |

**Notes:**

1. Pulse test,  $t \leq 300\mu\text{s}$ , duty cycle,  $d \leq 2\%$ .
2. Switching times & energy losses may increase for higher  $V_{CE}$ (Clamp),  $T_J$  or  $R_G$ .

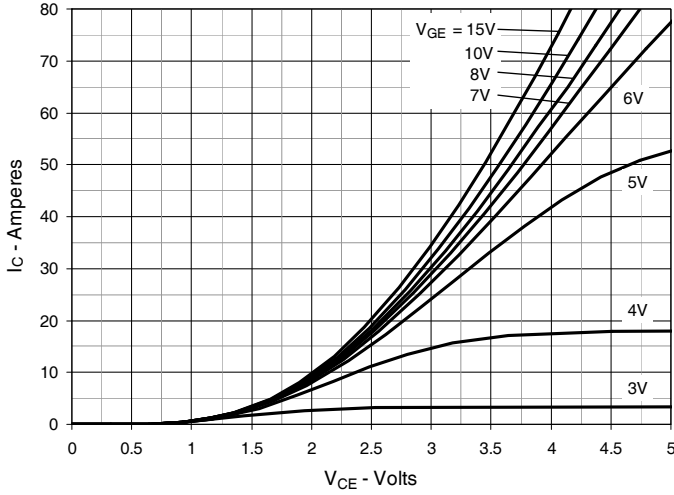
**ADVANCE TECHNICAL INFORMATION**

The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

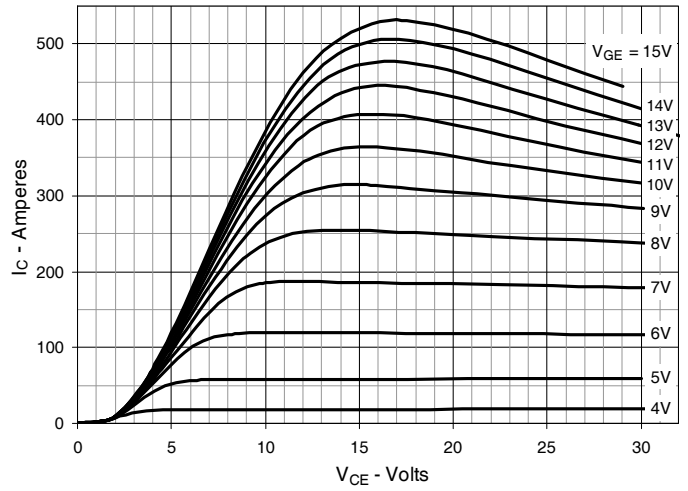
IXYS Reserves the Right to Change Limits, Test Conditions, and Dimensions.

|   |           |           |           |           |              |              |              |              |              |             |
|---|-----------|-----------|-----------|-----------|--------------|--------------|--------------|--------------|--------------|-------------|
| IXYS MOSFETs and IGBTs are covered            | 4,835,592 | 4,931,844 | 5,049,961 | 5,237,481 | 6,162,665    | 6,404,065 B1 | 6,683,344    | 6,727,585    | 7,005,734 B2 | 7,157,338B2 |
| by one or more of the following U.S. patents: | 4,860,072 | 5,017,508 | 5,063,307 | 5,381,025 | 6,259,123 B1 | 6,534,343    | 6,710,405 B2 | 6,759,692    | 7,063,975 B2 |             |
|   | 4,881,106 | 5,034,796 | 5,187,117 | 5,486,715 | 6,306,728 B1 | 6,583,505    | 6,710,463    | 6,771,478 B2 | 7,071,537    |             |

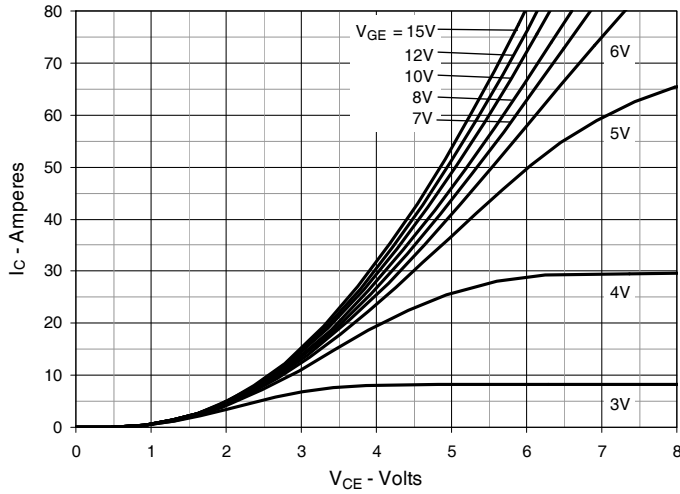
**Fig. 1. Output Characteristics @  $T_J = 25^\circ\text{C}$**



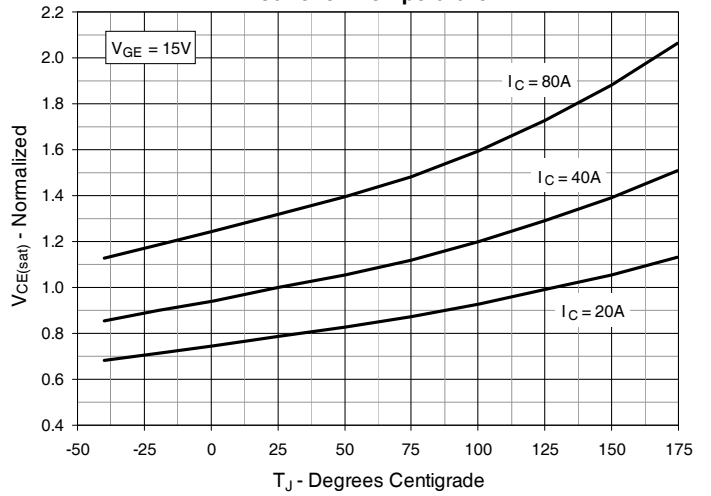
**Fig. 2. Extended Output Characteristics @  $T_J = 25^\circ\text{C}$**



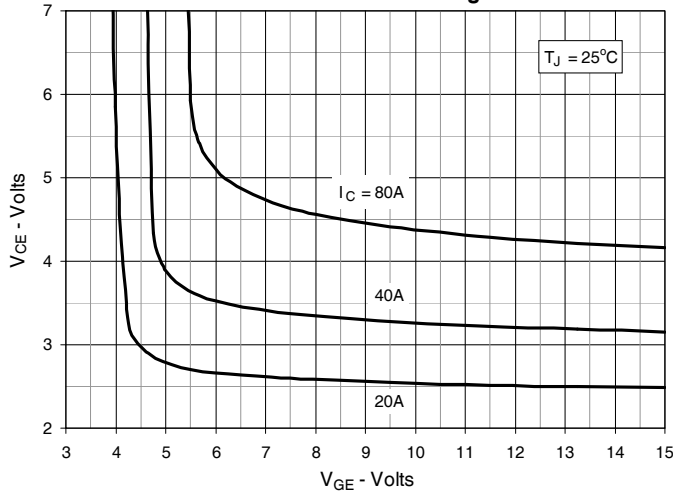
**Fig. 3. Output Characteristics @  $T_J = 150^\circ\text{C}$**



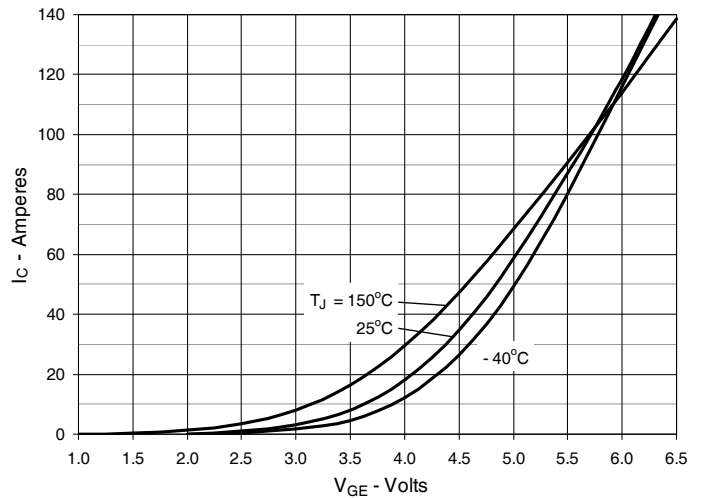
**Fig. 4. Dependence of  $V_{CE(sat)}$  on Junction Temperature**

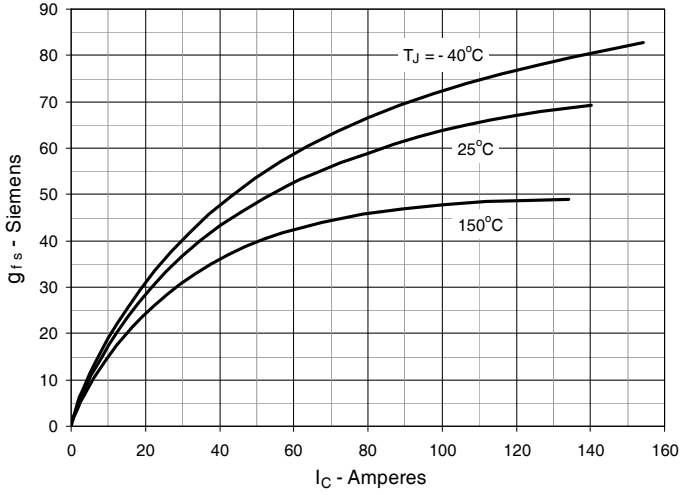
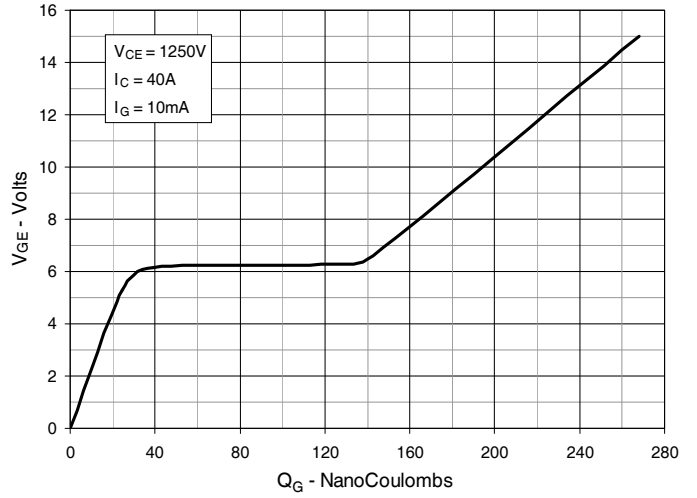
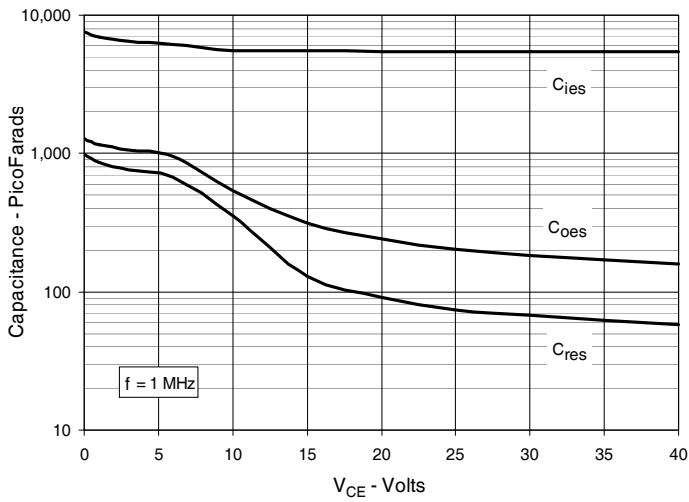
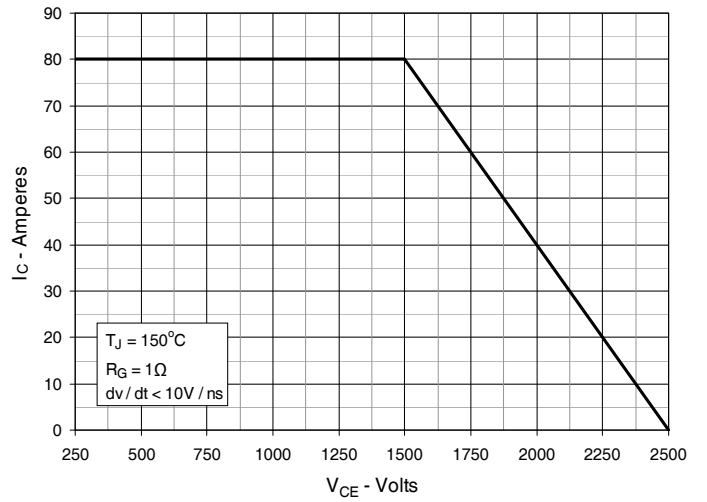
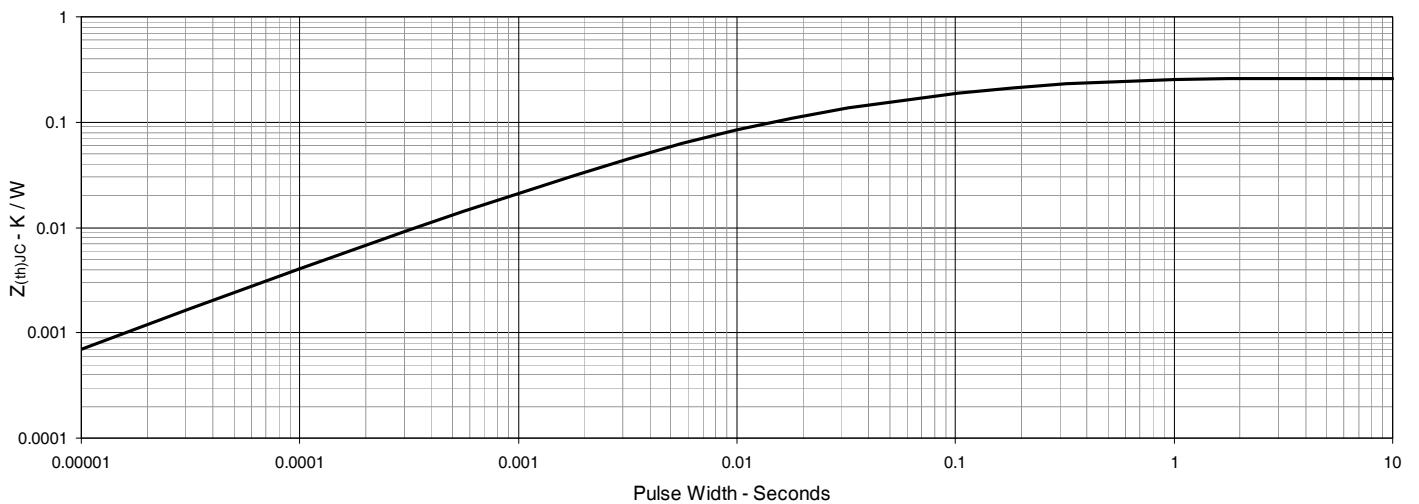


**Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter Voltage**

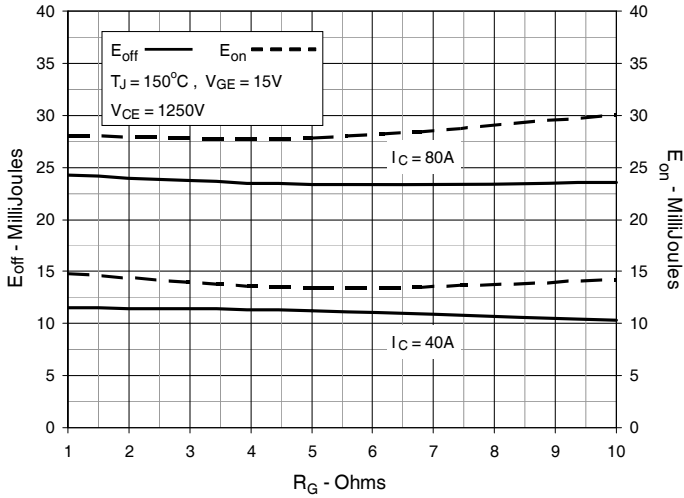


**Fig. 6. Input Admittance**

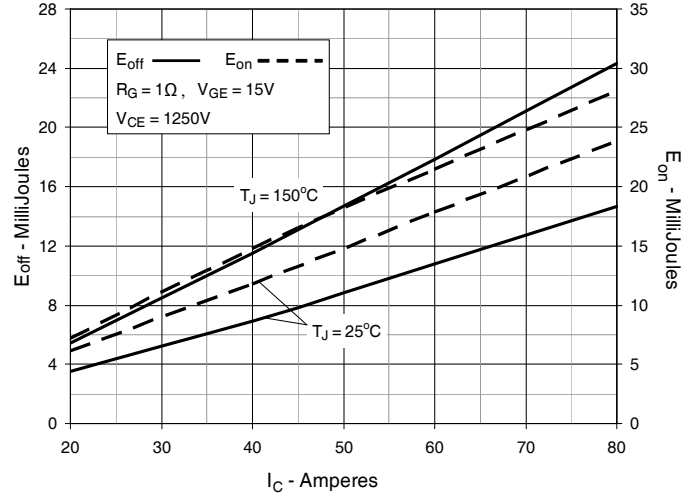


**Fig. 7. Transconductance**

**Fig. 8. Gate Charge**

**Fig. 9. Capacitance**

**Fig. 10. Reverse-Bias Safe Operating Area**

**Fig. 11. Maximum Transient Thermal Impedance**


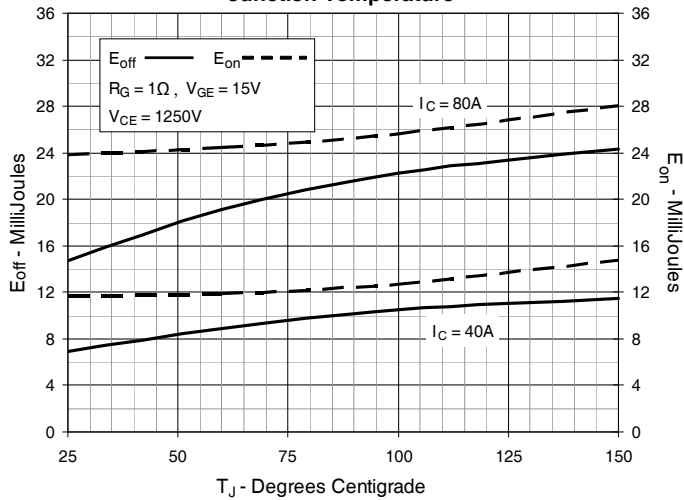
**Fig. 12. Inductive Switching Energy Loss vs. Gate Resistance**



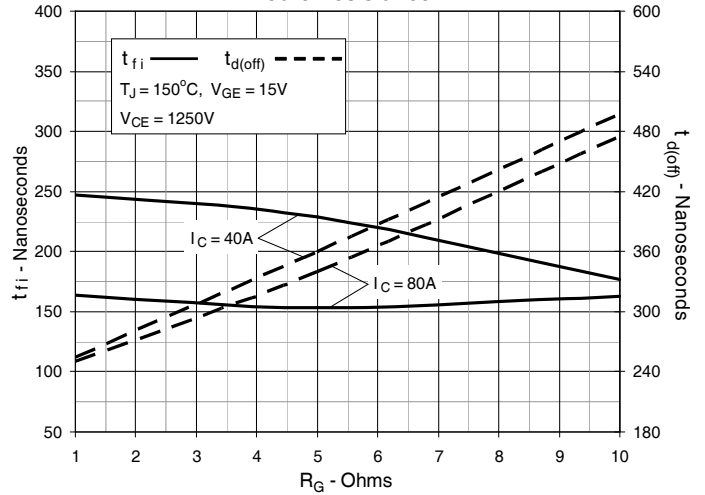
**Fig. 13. Inductive Switching Energy Loss vs. Collector Current**



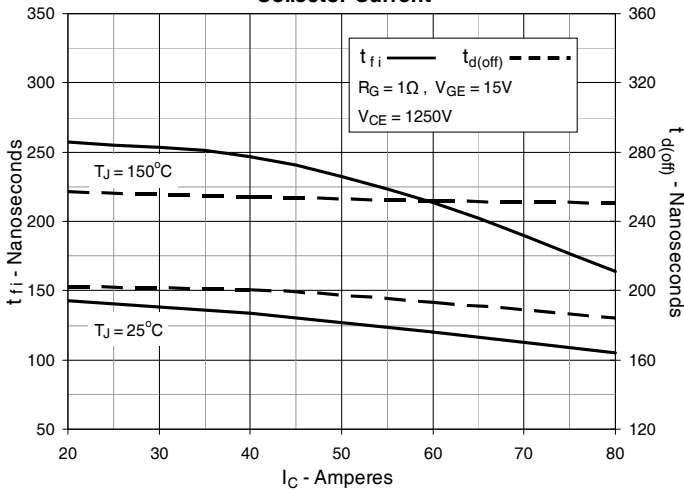
**Fig. 14. Inductive Switching Energy Loss vs. Junction Temperature**



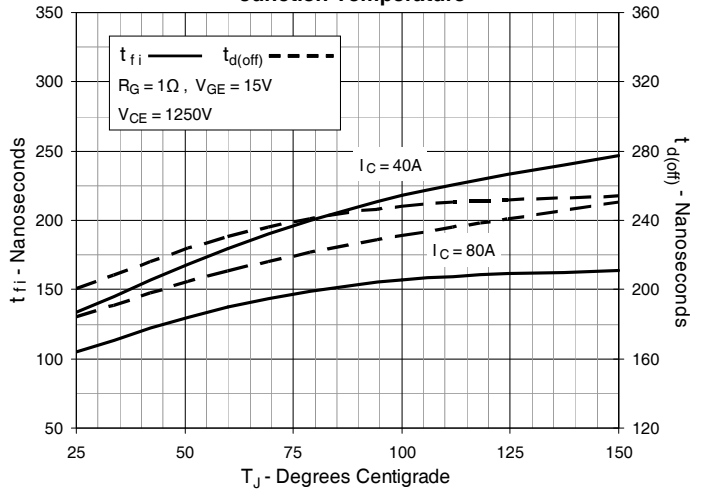
**Fig. 15. Inductive Turn-off Switching Times vs. Gate Resistance**

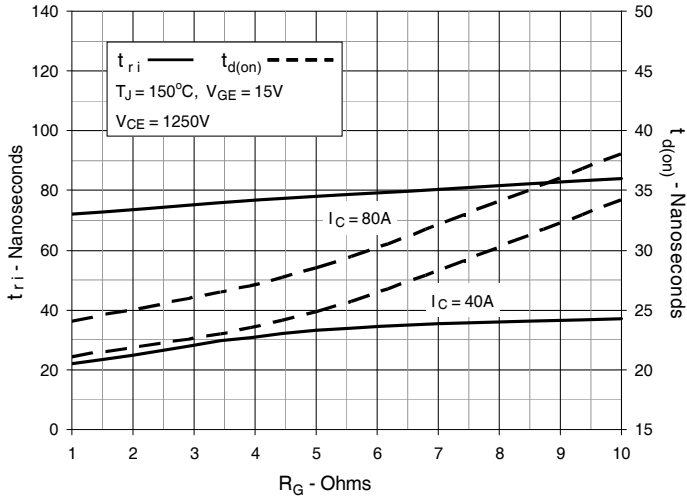
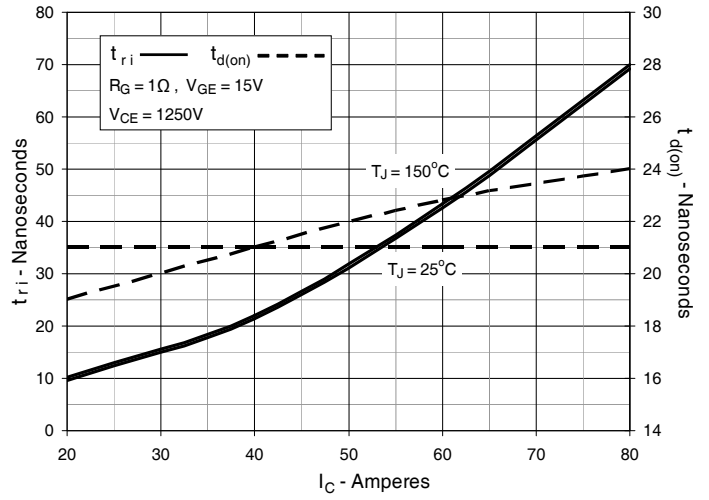
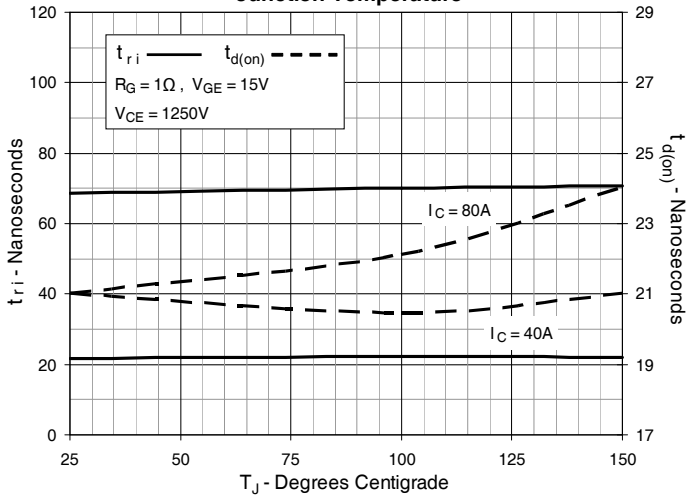


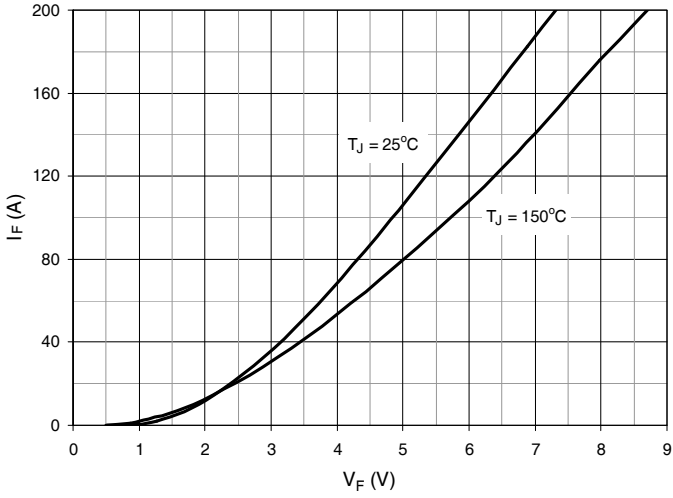
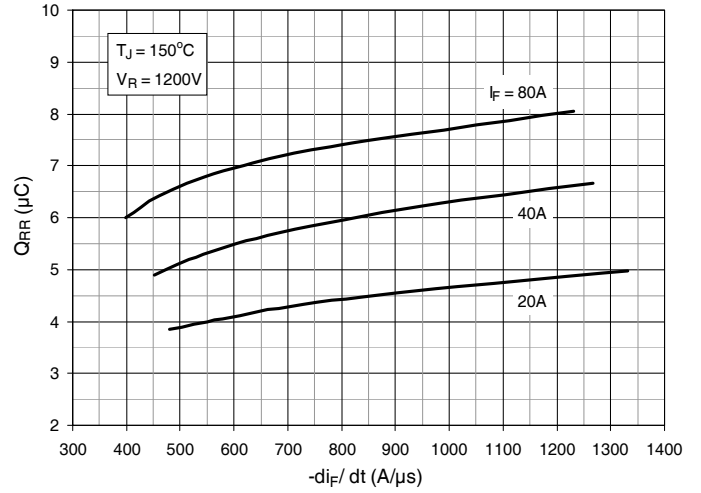
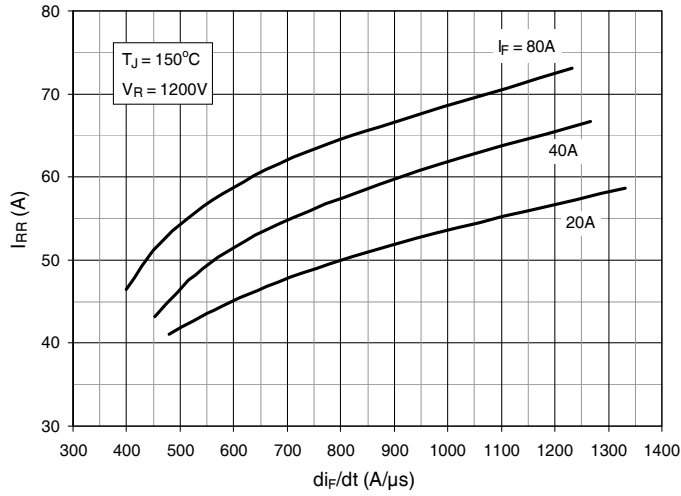
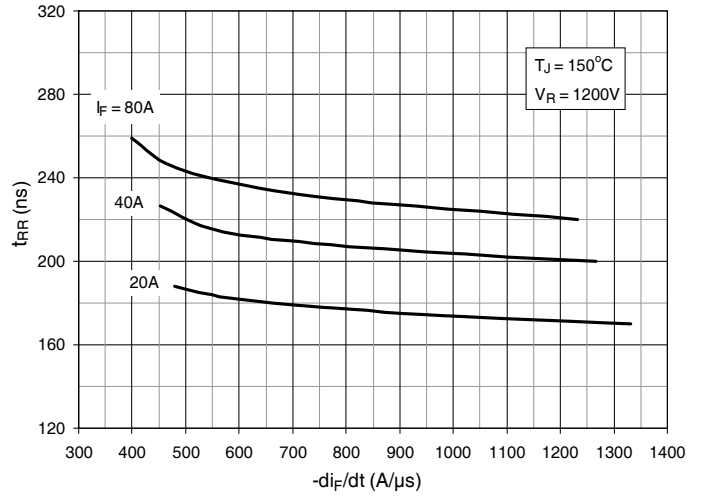
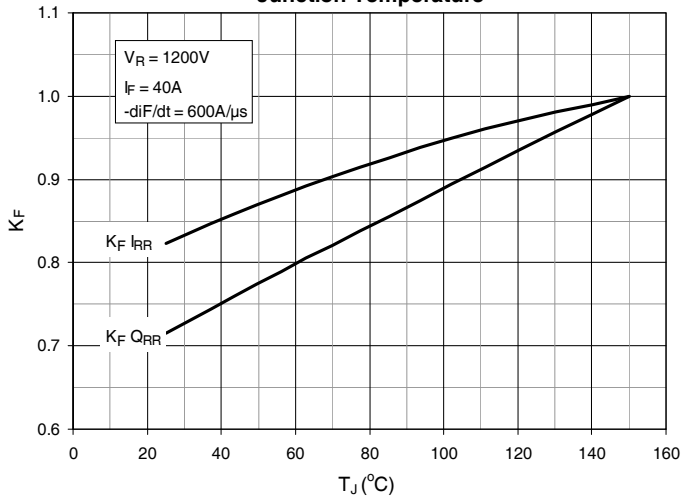
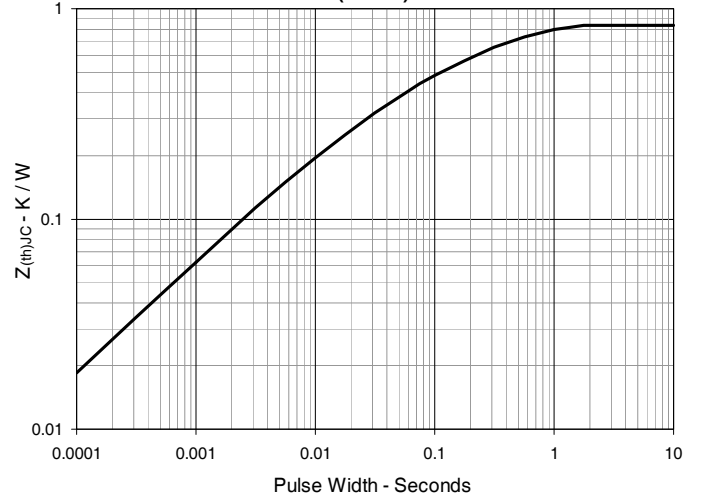
**Fig. 16. Inductive Turn-off Switching Times vs. Collector Current**

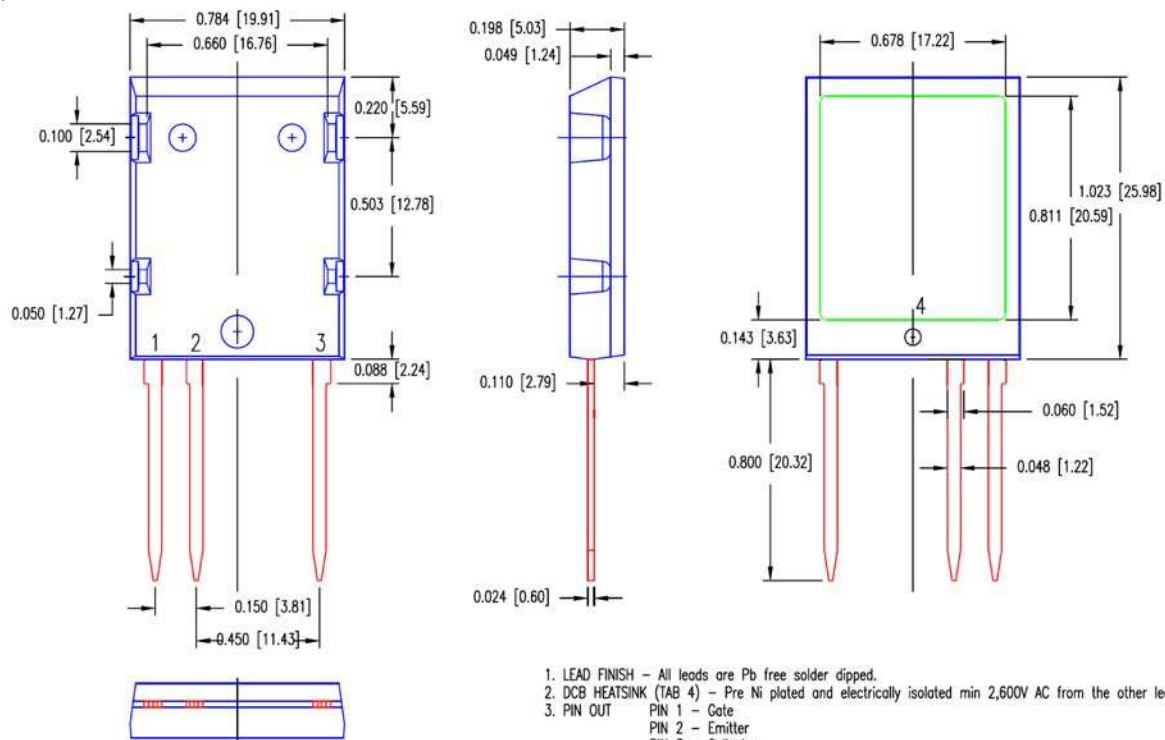


**Fig. 17. Inductive Turn-off Switching Times vs. Junction Temperature**



**Fig. 18. Inductive Turn-on Switching Times vs. Gate Resistance**

**Fig. 19. Inductive Turn-on Switching Times vs. Collector Current**

**Fig. 20. Inductive Turn-on Switching Times vs. Junction Temperature**


**Fig. 21. Diode Forward Characteristics**

**Fig. 22. Reverse Recovery Charge vs.  $-di_F/dt$** 

**Fig. 23. Reverse Recovery Current vs.  $-di_F/dt$** 

**Fig. 24. Reverse Recovery Time vs.  $-di_F/dt$** 

**Fig. 25. Dynamic Parameters  $Q_{RR}$ ,  $I_{RR}$  vs. Junction Temperature**

**Fig. 26. Maximum Transient Thermal Impedance (Diode)**


**ISOPLUS i5-Pak™ (IXYL) Outline**


1. LEAD FINISH – All leads are Pb free solder dipped.
2. DCB HEATSINK (TAB 4) – Pre Ni plated and electrically isolated min 2,600V AC from the other leads.
3. PIN OUT
  - PIN 1 – Gate
  - PIN 2 – Emitter
  - PIN 3 – Collector
  - TAP 4 – Isolated DCB Cu





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